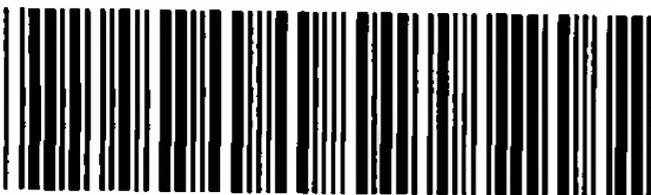


Search Notes



Application/Control No.

10/664 875

Examiner

Junghwa M. Im

**Applicant(s)/Patent under
Reexamination**

MATSUBARA ET AL.

Art Unit

2811

SEARCHED

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner